Searci	h Notes

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/659,101	CHAN ET AL.	
Examiner	Art Unit	
Randall Chin	1744	•

	SEARCHED		
Class	Subclass	Oate	Examiner
15	143.1	1	V
15	167.1	8/1/2005	RC
15	22.1	V	1
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		10/19/06	Re
UPDATE	D SKRH	1/30/07	Re

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PG-A	BTXT		
SRCH-			
SRCH	415704		<b>V</b>
PRINTE	UT	1/30/07	RC
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor name search	8/1/2005	RC .
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